

Docket No.: W&B-INF-1944

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : ANDREAS FELBER ET AL.
Filed : CONCURRENTLY HEREWITH
Title : TEST STRUCTURE FOR DETERMINING A DOPING REGION
OF AN ELECTRODE CONNECTION BETWEEN A TRENCH
CAPACITOR AND A SELECTION TRANSISTOR IN A MEMORY
CELL ARRAY

INFORMATION DISCLOSURE STATEMENT

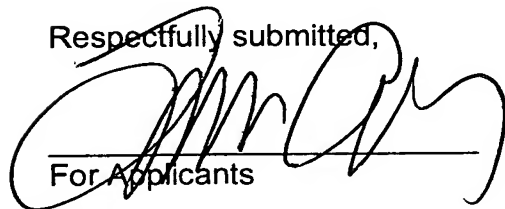
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

U.S. Patent No. 6,288,558 B1 (Zimmermann et al.), dated September 11, 2001, and corresponding German Published Non-Prosecuted Patent Application DE 101 07 081 A1 (Zimmermann et al.), dated September 13, 2001.

Respectfully submitted,



For Applicants

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Date: September 30, 2003

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FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Attorney Docket No.: W&B-INF-1944 Appl. No.: Applicant: ANDREAS FELBER ET AL. Filing Date: September 30, 2003 Group Art Unit:			
EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A	6,288,558 B1	9/11/01	Zimmermann et al.			
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						
FOREIGN PATENT DOCUMENT							
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	101 07 081 A1	9/13/01	Germany			
	K						
	L						
	M						
	N						
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER				DATE CONSIDERED			